

<b>Notice of References Cited</b>	Application/Control No. 10/779,793		Applicant(s)/Patent Under Reexamination LEE, SOO-JIN	
	Examiner Prabodh M. Dharia		Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0175908	11-2002	Ide, Shigeo	345/211
*	B	US-6,756,977	06-2004	Ide, Shigeo	345/212
*	C	US-6,388,678	05-2002	Kasahara et al.	345/690
*	D	US-7,075,560	07-2006	Ohe et al.	345/690
*	E	US-2004/0189569	09-2004	Ochi, Yutaka	345/089
*	F	US-6,249,268	06-2001	Tachibana et al.	345/89
*	G	US-2002/0003542	01-2002	TANAKA et al.	345/581
*	H	US-2002/0036650	03-2002	Kasahara et al.	345/639
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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